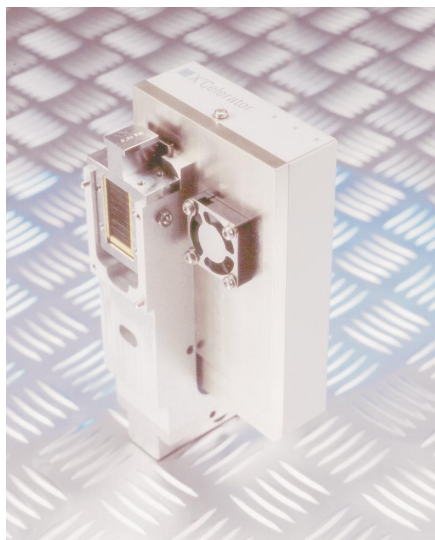


## Philips Analytical X'Celerator

Philips Analytical announces a new fast X-ray detector, the **X'Celerator**, offering a 100-fold increase in recording speed for powder diffractometry. Designed for the X'Pert PRO diffractometer series, the X'Celerator is based on the company's new real-time multiple-strip direction technology. This replaces a single detector with an integrated array of parallel detectors to provide up to 100-fold increase in efficiency compared with traditional detectors. This means a scan formerly requiring three hours of data-collection time can now be recorded in less than two minutes, with no compromise on resolution.

The new unit is mounted using the company's proprietary PreFIX interface, a design that allows for easy exchange of



**Figure 1**  
The Philips Analytical X'Celerator.

## new commercial products

Announcements of new commercial products are published by the *Journal of Applied Crystallography* free of charge. The descriptions, up to 300 words or the equivalent if a figure is included, should give the price and manufacturer's full address. Full or partial inclusion is subject to the approval of the Editor, to whom all correspondence should be sent. The International Union of Crystallography can assume no responsibility for the accuracy of the claims made.

optical components without laborious re-alignment procedures. Its design makes for simple, maintenance-free operation. It is available with several options including a diffracted-beam monochromator, a beta filter and exchangeable Soller slits. With its high speed and ultra-high resolution, it is expected to offer advantages and cost savings in almost every powder-diffractometry application such as phase identification and quantification, crystallography and residual stress analysis.

### Philips Analytical

Lelyweg 1  
7602 EA Almelo  
The Netherlands  
E-mail: [analytical.info@philips.com](mailto:analytical.info@philips.com)

### Free ORTEC application note: dealing with dead-time distortion in a time digitizer

A new **application note**, AN57 *Dealing with Dead Time Distortion in a Time Digitizer*, is available free of charge from ORTEC. AN57 examines the dead-time distortions inherent with time digitizers applied to high event rates. Some of the results are somewhat surprising. The application note also includes a practical scheme for making dead-time corrections to the time spectrum after the spectrum has been acquired. The principles are elucidated by typical applications in time-of-flight mass spectrometry, although they are also applicable to LIDAR, optics and nuclear spectrometry.

A free copy of AN57 can be ordered from [info\\_ORTEC@perkinelmer.com](mailto:info_ORTEC@perkinelmer.com), or downloaded from the application notes page of

the ORTEC web site at <http://www.ORTEC-online.com>.

### PerkinElmer Instruments

801 South Illinois Ave  
Oak Ridge  
Tennessee 37830  
USA  
E-mail: [info\\_ortec@perkinelmer.com](mailto:info_ortec@perkinelmer.com)

### Free ORTEC application note: how histogramming and counting statistics affect peak-position precision

A new **application note**, AN58 *How Histogramming and Counting Statistics Affect Peak Position Precision*, is available free of charge from ORTEC. AN58 investigates and defines the relative importance of the errors caused by counting statistics, differential non-linearity, and bin width when determining the position of a peak in a spectrum that has been recorded as a histogram. This study is aimed at time digitizers, multi-channel scalers and multichannel pulse-height analysers, where the counting of individual events follows Poisson statistics, but the results can be adapted to other instruments as well.

A free copy of AN58 can be ordered from [info\\_ORTEC@perkinelmer.com](mailto:info_ORTEC@perkinelmer.com), or downloaded from the application notes page of the ORTEC web site at <http://www.ORTEC-online.com>.

### PerkinElmer Instruments

801 South Illinois Ave  
Oak Ridge  
Tennessee 37830  
USA  
E-mail: [info\\_ortec@perkinelmer.com](mailto:info_ortec@perkinelmer.com)